

# LME49743 Quad High Performance, High Fidelity Audio Operational Amplifier

## **General Description**

The LME49743 is a low distortion, low noise, high slew rate operational amplifier optimized and fully specified for high performance, high fidelity applications. The LME49743 audio operational amplifier delivers superior audio signal amplification for outstanding audio performance. The LME49743 combines low voltage noise density (3.5nV/ $\sqrt{\rm Hz}$ ) and THD+N (0.0001%) to easily satisfy demanding audio applications. To ensure that the most challenging loads are driven without compromise, the LME49743 has a slew rate of  $\pm 12 \rm V/\mu s$  and an output current capability of  $\pm 21 \rm mA$ .

The LME49743's outstanding CMRR(106dB), PSRR(98dB), and  $\rm V_{OS}~(\pm 0.15 mV)$  give the amplifier excellent operational amplifier DC performance.

The LME49743 has a wide supply range of ±4.0V to ±17V. Over this supply range the LME49743's input circuitry maintains excellent common-mode, power supply rejection, and low input bias current. The LME49743 is unity gain stable.

The LME49743 is available in 14-lead TSSOP.

### **Key Specifications**

■ Power Supply Voltage Range	±4.0V to ±17V
■ THD+N ( $A_V = 1$ , $V_{OUT} = 3V_{RMS}$ ,	
$f_{IN} = 1kHz$	
$R_L = 2k\Omega$	0.0001% (typ)
$R_L = 600\Omega$	0.0001% (typ)
■ Input Noise Density	$3.5 \text{nV}/\sqrt{\text{Hz}}$ (typ)
■ Slew Rate	±12V/µs (typ)
■ Gain Bandwidth Product	30MHz (typ)
■ Open Loop Gain (R <sub>L</sub> = 600Ω)	110dB (typ)
■ Input Bias Current	190nA (typ)
■ Input Offset Voltage	±0.15mV (typ)

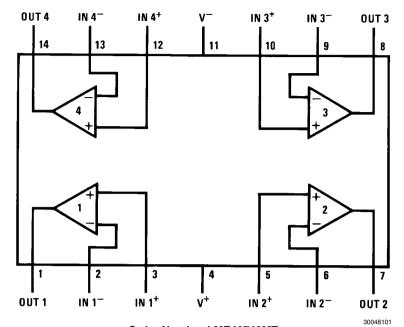
#### **Features**

- Easily drives 600Ω loads
- Optimized for superior audio signal fidelity
- Output short circuit protection
- 98dB (typ) PSRR and 106dB (typ) CMRR
- TSSOP package

## **Applications**

- Audio amplifiers and preamplifiers
- Professional Audio
- Equalization and crossover networks
- Line drivers and receivers
- Active filters

## **Connection Diagram**



Order Number LME49743MT See NS Package Number — MTC14

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## **Absolute Maximum Ratings** (Notes 1, 2)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Power Supply Voltage  $(V_S = V^+ - V^-)$ 

 $(V_S = V^+ - V^-)$  36V

Storage Temperature -65°C to 150°C

Input Voltage (V-) - 0.7V to (V+) + 0.7V

Output Short Circuit (Note 3) Continuous

Power Dissipation Internally Limited ESD Susceptibility (Note 4) 750V ESD Susceptibility (Note 5) 175V Junction Temperature 150°C

Thermal Resistance

 $\theta_{JA}$  (MT) 140°C/W

Temperature Range

 $T_{MIN} \le T_A \le T_{MAX}$   $-40^{\circ}C \le T_A \le 85^{\circ}C$ Supply Voltage Range  $\pm 4.0V \le V_S \le \pm 17V$ 

**Electrical Characteristics** (Notes 1, 2) The following specifications apply for  $V_S = \pm 15V$ ,  $R_L = 2k\Omega$ ,  $f_{IN} = 1kHz$ , and  $T_A = 25C$ , unless otherwise specified.

			LME49743		
Symbol	Parameter	Conditions	Typical Limit		Units
		Conditions	(Note 6)	(Notes 7, 8)	(Limits)
		$A_V = 1$ , $V_{OUT} = 3V_{RMS}$			
THD+N	Total Harmonic Distortion + Noise	$R_L = 2k\Omega$	0.0001		
		$R_L = 600\Omega$	0.0001	0.0002	% (max)
IMD	Intermodulation Distortion	$A_V = 1$ , $V_{OUT} = 3V_{RMS}$ Two-tone, 60Hz & 7kHz 4:1	0.0005		% (max)
GBWP	Gain Bandwidth Product		30	25	MHz (min)
SR	Slew Rate		12	9.5	V/µs (min)
FPBW	Full Power Bandwidth	V <sub>OUT</sub> = 1V <sub>P-P</sub> , -3dB referenced to output magnitude at f = 1kHz	10		MHz
t <sub>s</sub>	Settling time	$A_V = 1$ , 10V step, $C_L = 100$ pF 0.1% error range	1.2		μs
	Equivalent Input Noise Voltage	f <sub>BW</sub> = 20Hz to 20kHz	0.48	0.65	$\mu V_{RMS}$
e <sub>n</sub>	Equivalent Input Noise Density	f = 1kHz	3.5	4.5	nV/√Hz (max)
"		f = 10Hz	6.4	ļ	nV/√ <del>Hz</del>
	Current Noise Density	f = 1kHz	1.6		pA <b>/</b> √Hz
i <sub>n</sub>			3.1	ļ	pA/√Hz
V <sub>OS</sub>	Offset Voltage		±0.15	±1.0	mV (max)
ΔV <sub>OS</sub> /ΔTemp	Average Input Offset Voltage Drift vs Temperature	40°C ≤ T <sub>A</sub> ≤ 85°C	0.05		μV/°C
PSRR	Average Input Offset Voltage Shift vs Power Supply Voltage	ΔV <sub>S</sub> = 20V (Note 9)	98	94	dB (min)
180	Channel-to-Channel Isolation	f <sub>IN</sub> = 1kHz	118		dB
ISO <sub>CH-CH</sub>	Charmer to-Charmer isolation	f <sub>IN</sub> = 20kHz	112		dB
I <sub>B</sub>	Input Bias Current	$V_{CM} = 0V$	190	250	nA (max)
ΔI <sub>OS</sub> /ΔTemp	Input Bias Current Drift vs Temperature	-40°C ≤ T <sub>A</sub> ≤ 85°C	0.05		nA/°C
I <sub>os</sub>	Input Offset Current	$V_{CM} = 0V$	7	40	nA (max)
V <sub>IN-CM</sub>	Common-Mode Input Voltage Range		±13.2	(V+)-2.0 (V-)+2.0	V (min) V (min)
CMRR	Common-Mode Rejection	-10V <v<sub>CM&lt;10V</v<sub>	106	98	dB (min)
7	Differential Input Impedance		30		kΩ
Z <sub>IN</sub>	Common Mode Input Impedance	-10V <v<sub>CM&lt;10V</v<sub>	1000		MΩ
		$-10V < V_{OUT} < 10V, R_L = 600\Omega$	110		dB (min)
A <sub>VOL</sub>	Open Loop Voltage Gain	$-10V < V_{OUT} < 10V, R_L = 2k\Omega$	110		dB (min)
10L		$-10V < V_{OUT} < 10V, R_L = 10k\Omega$	110	100	dB (min)

Symbol	Parameter	Conditions	LME	49743	
			Typical	Limit	Units
			(Note 6)	(Notes 7,	(Limits)
				8)	
V <sub>OUTMAX</sub>	Maximum Output Voltage Swing	$R_L = 600\Omega$	±12.4	±12.0	V (min)
		$R_L = 2k\Omega$	±13.0		V (min)
		$R_L = 10k\Omega$	±13.0		V (min)
I <sub>OUT</sub>	Output Current	$R_L = 600\Omega, V_S = \pm 17V$	±21	±20	mA (min)
I <sub>OUT-CC</sub>	Short Circuit Current		+30		mA
			-38		mA
		f <sub>IN</sub> = 10kHz			
R <sub>OUT</sub>		Closed-Loop	0.01		Ω
		Open-Loop	13		Ω
C <sub>LOAD</sub>	Capacitive Load Drive Overshoot	100pF	16		%
I <sub>s</sub>	Total Quiescent Current	I <sub>OUT</sub> = 0mA	10	14	mA (max)

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur.

**Note 2:** Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

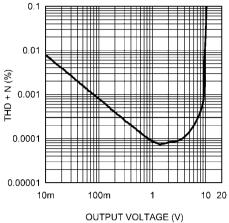
- Note 3: Amplifier output connected to GND, any number of amplifiers within a package.
- Note 4: Human body model, 100pF discharged through a 1.5k $\Omega$  resistor.
- Note 5: Machine Model ESD test is covered by specification EIAJ IC-121-1981. A 200pF cap is charged to the specified voltage and then discharged directly into the IC with no external series resistor (resistance of discharge path must be under  $50\Omega$ ).

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- Note 6: Typical specifications are specified at +25°C and represent the most likely parametric norm.
- Note 7: Tested limits are guaranteed to National's AOQL (Average Outgoing Quality Level).
- Note 8: Datasheet min/max specification limits are guaranteed by design, test, or statistical analysis.
- Note 9: PSRR is measured as follows:  $V_{OS}$  is measured at two supply voltages,  $\pm 5V$  and  $\pm 15V$ . PSRR =  $|20log(\Delta V_{OS}/\Delta V_S)|$ .

## **Typical Performance Characteristics**

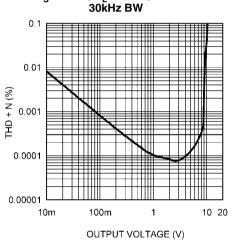
## THD+N vs Output Voltage $V_S = \pm 15V$ , $R_L = 2k\Omega$ , f = 1kHz 30kHz BW



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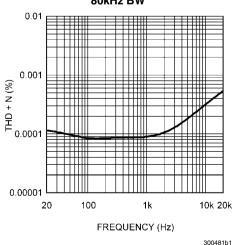
# THD+N vs Output Voltage

 $V_S = \pm 15V, R_L = 600\Omega, f = 1kHz$ 

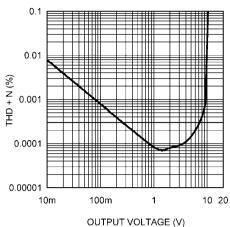


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# THD+N vs Frequency $V_S = \pm 15 V, \, V_{OUT} = 3 V_{RMS}, \, R_L = 10 k\Omega$ 80kHz BW

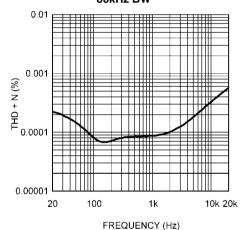


THD+N vs Output Voltage  $V_S = \pm 15V, R_L = 10k\Omega, f = 1kHz$  30kHz BW



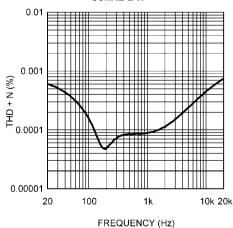
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## THD+N vs Frequency $V_S = \pm 15V, \, V_{OUT} = 3V_{RMS}, \, R_L = 2k\Omega$ 80kHz BW

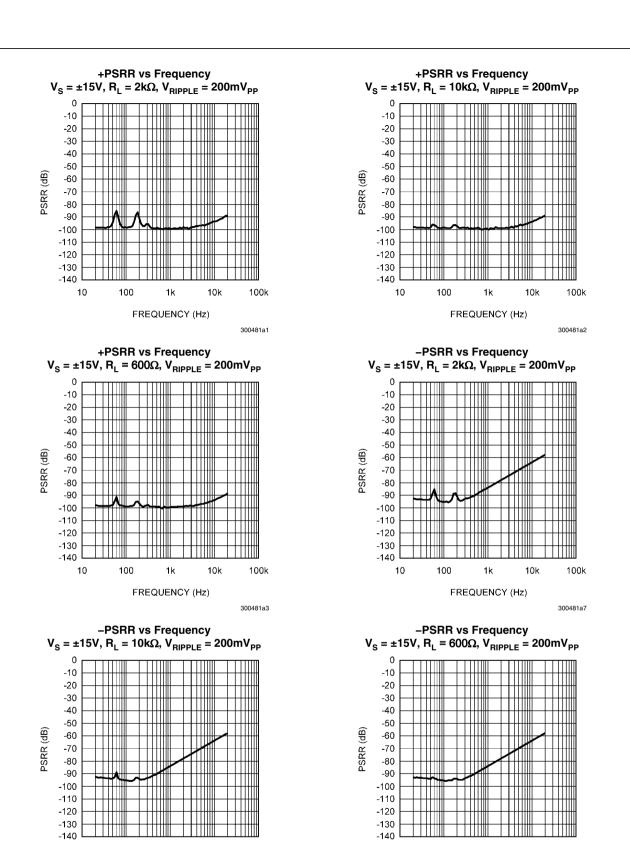


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# THD+N vs Frequency $V_S = \pm 15 V, \, V_{OUT} = 3 V_{RMS}, \, R_L = 600 \Omega$ 80kHz BW



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10

100

1k

FREQUENCY (Hz)

10k

100k

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10

100

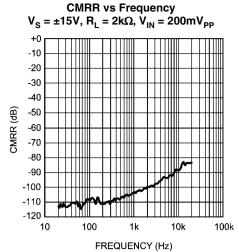
1k

FREQUENCY (Hz)

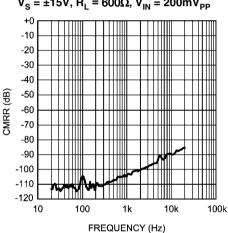
10k

100k

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30048189 **CMRR vs Frequency**  $V_S = \pm 15V$ ,  $R_L = 600\Omega$ ,  $V_{IN} = 200 \text{mV}_{PP}$ 

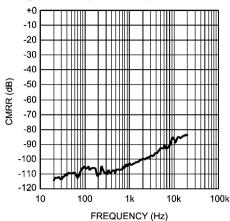


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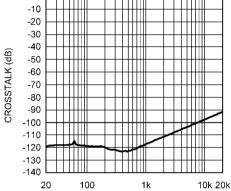
Crosstalk vs Frequency  $V_S = \pm 15V$ ,  $V_{OUT} = 3V_{RMS}$ ,  $R_L = 10k\Omega$ -10 -20 -30 -40 CROSSTALK (dB) -50 -60 -70 -80 -90 -100 -110 -120 -130 -140 20 100 10k 20k 1k FREQUENCY (Hz)

**CMRR vs Frequency**  $V_{S} = \pm 15V, R_{L} = 10k\Omega, V_{IN} = 200mV_{PP}$ 



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Crosstalk vs Frequency  $V_S = \pm 15V$ ,  $V_{OUT} = 3V_{BMS}$ ,  $R_L = 2k\Omega$ -10 -20 -30 -40 -50

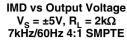


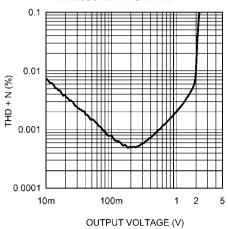
FREQUENCY (Hz)

300481b9 Crosstalk vs Frequency

 $V_S = \pm 15V$ ,  $V_{OUT} = 3V_{RMS}$ ,  $R_L = 600\Omega$ -10 -20 -30 -40 CROSSTALK (dB) -50 -60 -70 -80 -90 -100 -110 -120 -130 -140 20 100 10k 20k 1k FREQUENCY (Hz)

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# 0.01 HDH 0.001

IMD vs Output Voltage  $V_S = \pm 5V, R_L = 10k\Omega$  7kHz/60Hz 4:1 SMPTE

0.1

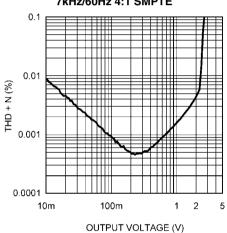
0.0001

10m

OUTPUT VOLTAGE (V)

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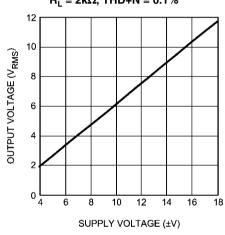
# IMD vs Output Voltage $V_S = \pm 5V, R_L = 600\Omega$ 7kHz/60Hz 4:1 SMPTE



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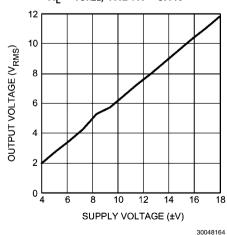
## Output Voltage vs Supply Voltage $R_L = 2k\Omega,\, THD + N = 0.1\%$

100m

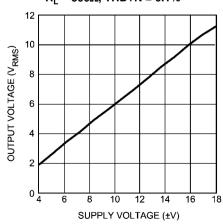


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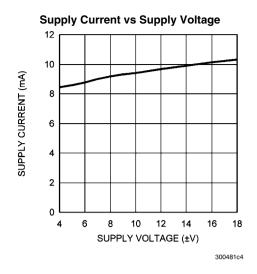
## Output Voltage vs Supply Voltage $R_L = 10k\Omega$ , THD+N = 0.1%

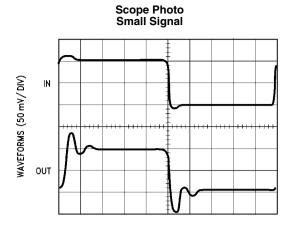


Output Voltage vs Supply Voltage  $R_L = 600\Omega,\, THD + N = 0.1\%$ 



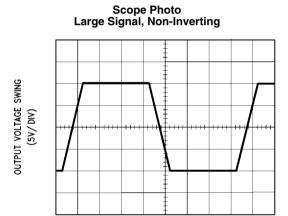
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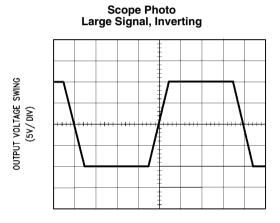




TIME (0.1 µs / DIV)

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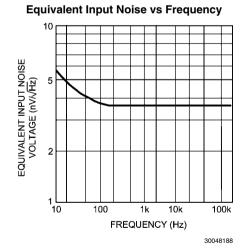


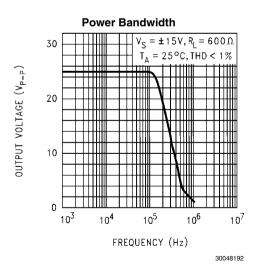


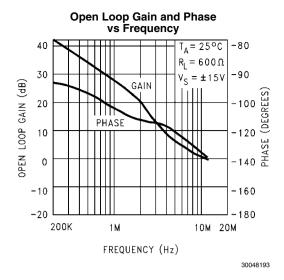
TIME (1  $\mu s$  / DIV)

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TIME (1  $\mu$ s / DIV)







## **Application Information**

#### **DISTORTION MEASUREMENTS**

The vanishingly low residual distortion produced by LME49743 is below the capabilities of all commercially available equipment. This makes distortion measurements just slightly more difficult than simply connecting a distortion meter to the amplifier's inputs and outputs. The solution, however, is quite simple: an additional resistor. Adding this resistor extends the resolution of the distortion measurement equipment.

The LME49743's low residual distortion is an input referred internal error. As shown in Figure 1, adding the  $10\Omega$  resistor connected between the amplifier's inverting and non-inverting

inputs changes the amplifier's noise gain. The result is that the error signal (distortion) is amplified by a factor of 101. Although the amplifier's closed-loop gain is unaltered, the feedback available to correct distortion errors is reduced by 101, which means that measurement resolution increases by 101. To ensure minimum effects on distortion measurements, keep the value of R1 low as shown in Figure 1.

This technique is verified by duplicating the measurements with high closed loop gain and/or making the measurements at high frequencies. Doing so produces distortion components that are within the measurement equipment's capabilities. This datasheet's THD+N and IMD values were generated using the above described circuit connected to an Audio Precision System Two Cascade.

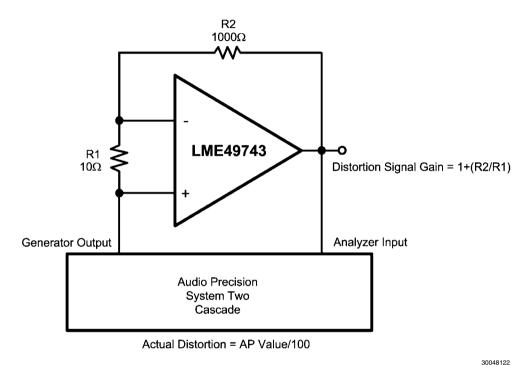


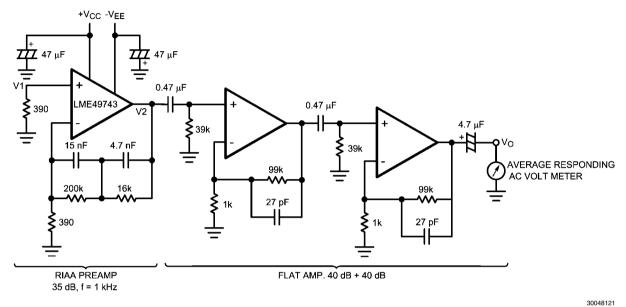
FIGURE 1. THD+N and IMD Distortion Test Circuit

## **Application Hints**

The LME49743 is a high speed op amp with excellent phase margin and stability. Capacitive loads up to 100pF will cause little change in the phase characteristics of the amplifiers and are therefore allowable.

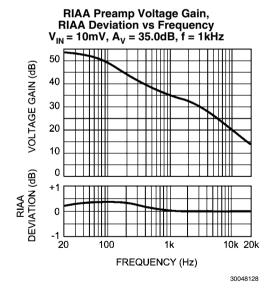
Capacitive loads greater than 100pF must be isolated from the output. The most straightforward way to do this is to put a resistor in series with the output. This resistor will also prevent excess power dissipation if the output is accidentally shorted.

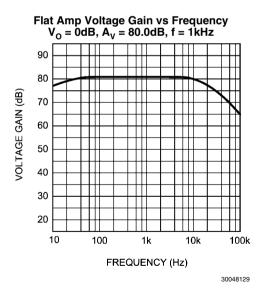
#### **Noise Measurement Circuit**



Complete shielding is required to prevent induced pick up from external sources. Always check with oscilloscope for power line noise.

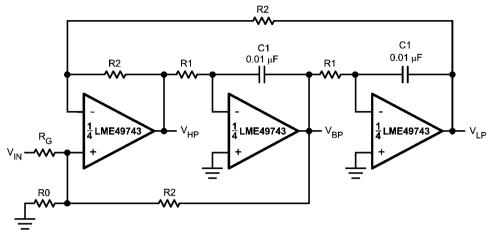
#### Total Gain: 115 dB at f = 1 kHz Input Referred Noise Voltage: e<sub>n</sub> = V<sub>O</sub>/560,000 (V)





## **Typical Applications**

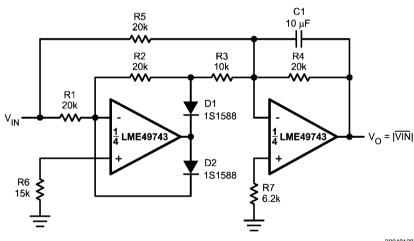
#### State Variable Filter



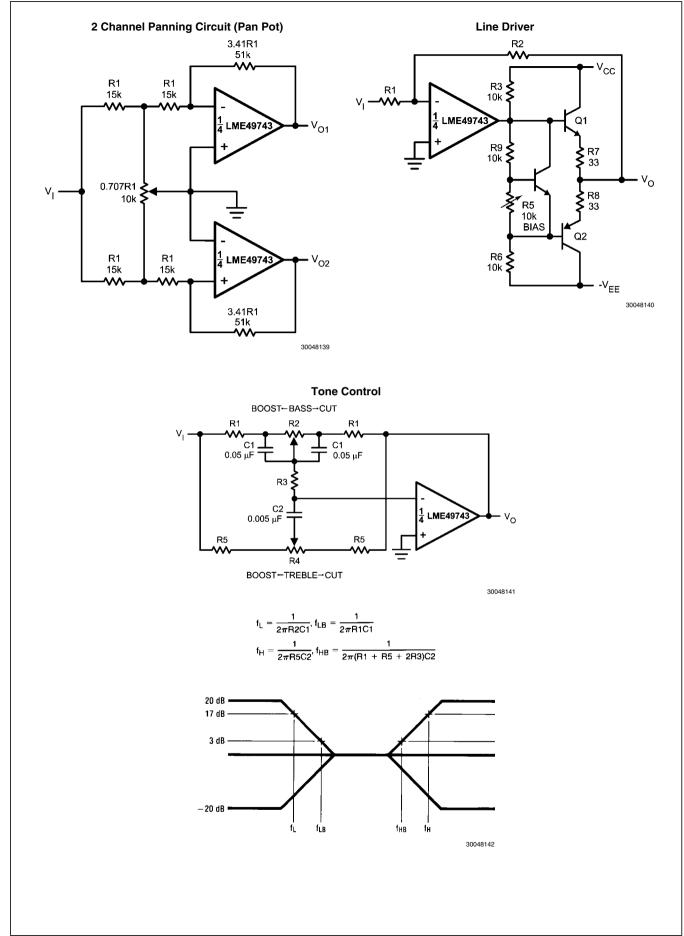
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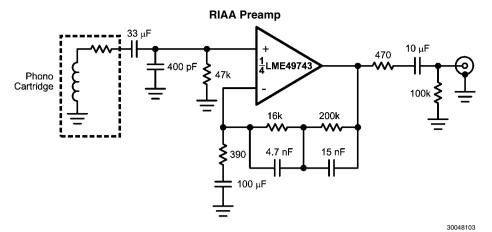
$$f_0 = \frac{1}{2\pi C1R1}, Q = \frac{1}{2}\left(1 + \frac{R2}{R0} + \frac{R2}{RG}\right), A_{BP} = QA_{LP} = QA_{LH} = \frac{R2}{RG}$$

#### **AC/DC Converter**



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 $\begin{array}{l} A_{\nu}=35~dB\\ E_{n}=0.33~\mu V\\ S/N=90~dB\\ f=1~kHz\\ A~Weighted\\ A~Weighted,~V_{IN}=10~mV\\ @~f=1~kHz\\ \end{array}$ 

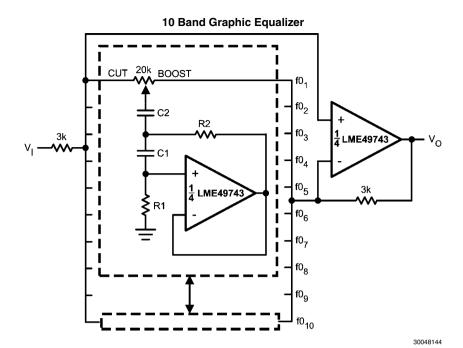
## **Balanced Input Mic Amp** R3 R4 10k 10k LME49743 R2 10k 1/4 LME49743 R1 \$ R5 10k R6 R7 10k 10k 1/4 LME49743

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If R2 = R5, R3 = R6, R4 = R7  

$$V0 = \left(1 + \frac{2R2}{R1}\right) \frac{R4}{R3} (V2 - V1)$$

Illustration is: V0 = 101(V2 - V1)



fo (Hz)	C <sub>1</sub>	C <sub>2</sub>	R <sub>1</sub>	R <sub>2</sub>
32	0.12µF	4.7µF	75kΩ	500Ω
64	0.056µF	3.3µF	68kΩ	510Ω
125	0.033µF	1.5µF	62kΩ	510Ω
250	0.015µF	0.82µF	68kΩ	470Ω
500	8200pF	0.39µF	62kΩ	470Ω
1k	3900pF	0.22µF	68kΩ	470Ω
2k	2000pF	0.1µF	68kΩ	470Ω
4k	1100pF	0.056µF	62kΩ	470Ω
8k	510pF	0.022µF	68kΩ	510Ω
16k	330pF	0.012µF	51kΩ	510Ω

Note 10: At volume of change =  $\pm 12 \text{ dB}$ 

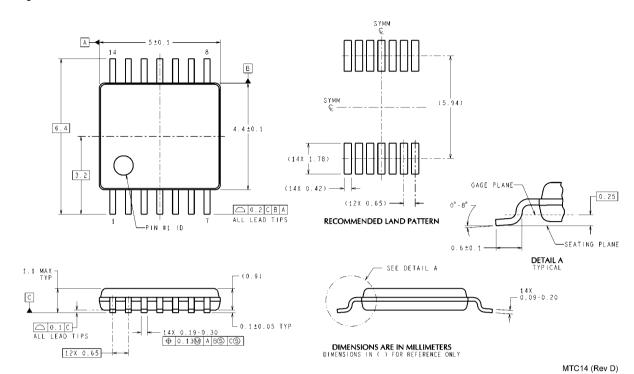
Q = 1.7

Reference: "AUDIO/RADIO HANDBOOK", National Semiconductor, 1980, Page 2-61

## **Revision History**

Rev	Date	Description
1.0	03/26/08	Initial release.
1.01	01/12/09	Fixed a typo.

## Physical Dimensions inches (millimeters) unless otherwise noted



Dual-In-Line Package Order Number LME49743MT NS Package Number MTC14

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### **Notes**

For more National Semiconductor product information and proven design tools, visit the following Web sites at:

oducts	Design Support		
www.national.com/amplifiers	WEBENCH® Tools	www.national.com/webench	
www.national.com/audio	App Notes	www.national.com/appnotes	
www.national.com/timing	Reference Designs	www.national.com/refdesigns	
www.national.com/adc	Samples	www.national.com/samples	
www.national.com/interface	Eval Boards	www.national.com/evalboards	
www.national.com/lvds	Packaging	www.national.com/packaging	
www.national.com/power	Green Compliance	www.national.com/quality/green	
www.national.com/switchers	Distributors	www.national.com/contacts	
www.national.com/ldo	Quality and Reliability	www.national.com/quality	
www.national.com/led	Feedback/Support	www.national.com/feedback	
www.national.com/vref	Design Made Easy	www.national.com/easy	
www.national.com/powerwise	Solutions	www.national.com/solutions	
www.national.com/sdi	Mil/Aero	www.national.com/milaero	
www.national.com/tempsensors	Solar Magic®	www.national.com/solarmagic	
www.national.com/wireless	Analog University®	www.national.com/AU	
	www.national.com/amplifiers www.national.com/audio www.national.com/timing www.national.com/adc www.national.com/interface www.national.com/lvds www.national.com/power www.national.com/switchers www.national.com/ldo www.national.com/led www.national.com/ref www.national.com/powerwise www.national.com/sdi www.national.com/sdi	www.national.com/amplifiers WEBENCH® Tools www.national.com/audio App Notes www.national.com/timing Reference Designs www.national.com/adc Samples www.national.com/interface Eval Boards www.national.com/lvds Packaging www.national.com/power Green Compliance www.national.com/switchers Distributors www.national.com/ldo Quality and Reliability www.national.com/led Feedback/Support www.national.com/vref Design Made Easy www.national.com/powerwise Solutions www.national.com/sdi Mil/Aero www.national.com/stempsensors Solar Magic®	

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